

OptiMOS™ 2 Power-Transistor
Features

- Fast switching MOSFET for SMPS
- Optimized technology for notebook DC/DC
- Qualified according to JEDEC¹ for target applications

Thermal resistance, junction - soldering point

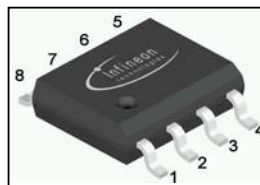
Thermal resistance, junction - ambient

- Excellent gate charge $\times R_{DS(on)}$ product (FOM)
- Very low on-resistance $R_{DS(on)}$
- Avalanche rated
- dv/dt rated
- Pb-free plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

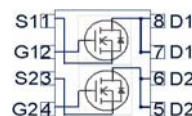
Product Summary

V_{DS}	30	V
$R_{DS(on),max}$	20	m Ω
I_D	7.9	A

P-DSO-8



Type	Package	Marking
BSO200N03	PG-DSO-8	200N3


Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value		Unit
			10 secs	steady state	
Continuous drain current	I_D	$T_A=25\text{ }^\circ\text{C}^{(2)}$	7.9	6.6	A
		$T_A=70\text{ }^\circ\text{C}^{(2)}$	6.3	5.3	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ }^\circ\text{C}^{(3)}$	32		
Avalanche energy, single pulse	E_{AS}	$I_D=7.9\text{ A}, R_{GS}=25\text{ }\Omega$	27		mJ
Reverse diode dv/dt	dv/dt	$I_D=7.9\text{ A}, V_{DS}=20\text{ V}, di/dt=200\text{ A}/\mu\text{s}, T_{j,max}=150\text{ }^\circ\text{C}$	6		kV/ μs
Gate source voltage	V_{GS}		± 20		V
Power dissipation	P_{tot}	$T_A=25\text{ }^\circ\text{C}^{(2)}$	2.0	1.4	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150		$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1			55/150/56		

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - soldering point	R_{thJS}		-	-	50	K/W
Thermal resistance, junction - ambient	R_{thJA}	minimal footprint, $t_p \leq 10$ s	-	-	110	
		minimal footprint, steady state	-	-	150	
		6 cm ² cooling area ²⁾ , $t_p \leq 10$ s	-	-	63	
		6 cm ² cooling area ²⁾ , steady state	-	-	90	

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified
Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0$ V, $I_D=1$ mA	30	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=13$ μ A	1.2	1.6	2	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=30$ V, $V_{GS}=0$ V, $T_j=25$ °C	-	0.1	1	μ A
		$V_{DS}=30$ V, $V_{GS}=0$ V, $T_j=125$ °C	-	10	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=20$ V, $V_{DS}=0$ V	-	10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=4.5$ V, $I_D=6.8$ A	-	21.7	27	m Ω
		$V_{GS}=10$ V, $I_D=7.9$ A	-	16.7	20	
Gate resistance	R_G		-	1.5	-	Ω
Transconductance	g_{fs}	$ V_{DS} > 2 I_D R_{DS(on)max}$, $I_D=7.9$ A	9	18	-	S

¹⁾J-STD20 and JESD22

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See figure 3

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Thermal resistance,	$j_l C_{iss}$	$V_{GS}=0\text{ V}, V_{DS}=15\text{ V},$ $f=1\text{ MHz}$	-	756	1010	pF
Thermal resistance,	$j_c C_{oss}$		-	270	360	
Reverse transfer capacitance	C_{rss}		-	37	56	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=15\text{ V}, V_{GS}=10\text{ V},$ $I_D=3.9\text{ A}, R_G=2.7\ \Omega$	-	3.9	5.8	ns
Rise time	t_r		-	3.2	4.8	
Turn-off delay time	$t_{d(off)}$		-	14	22	
Fall time	t_f		-	2.2	3.3	

Gate Charge Characteristics⁴⁾

Gate to source charge	Q_{gs}	$V_{DD}=15\text{ V}, I_D=3.9\text{ A},$ $V_{GS}=0\text{ to }5\text{ V}$	-	2.2	2.9	nC
Gate charge at threshold	$Q_{g(th)}$		-	1.2	1.6	
Gate to drain charge	Q_{gd}		-	1.5	2.3	
Switching charge	Q_{sw}		-	2.5	3.5	
Gate charge total	Q_g		-	6	8	
Gate plateau voltage	$V_{plateau}$		-	2.9	-	
Gate charge total, sync. FET	$Q_{g(sync)}$	$V_{DS}=0.1\text{ V},$ $V_{GS}=0\text{ to }5\text{ V}$	-	5.1	7	nC
Output charge	Q_{oss}	$V_{DD}=15\text{ V}, V_{GS}=0\text{ V}$	-	6	8	

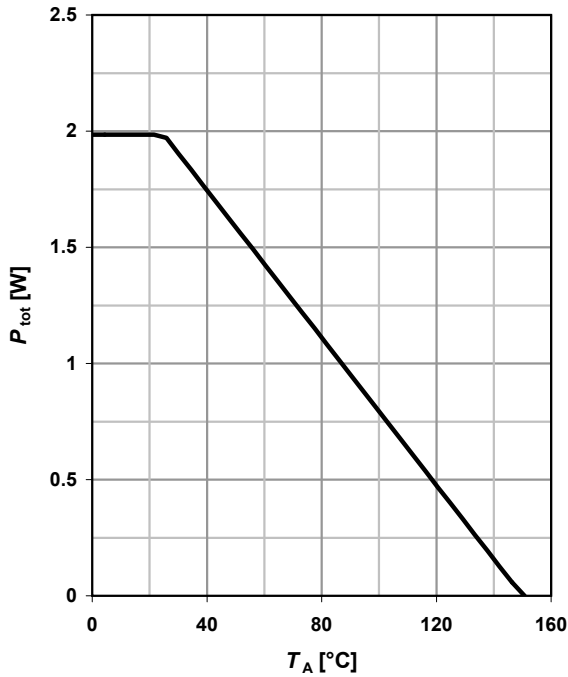
Reverse Diode

Diode continuous forward current	I_S	$T_A=25\text{ }^\circ\text{C}$	-	-	2	A
Diode pulse current	$I_{S,pulse}$		-	-	32	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=2\text{ A},$ $T_j=25\text{ }^\circ\text{C}$	-	0.77	1	V
Reverse recovery charge	Q_{rr}	$V_R=12\text{ V}, I_F=I_S,$ $di_F/dt=400\text{ A}/\mu\text{s}$	-	-	8	nC

⁴⁾ See figure 16 for gate charge parameter definition

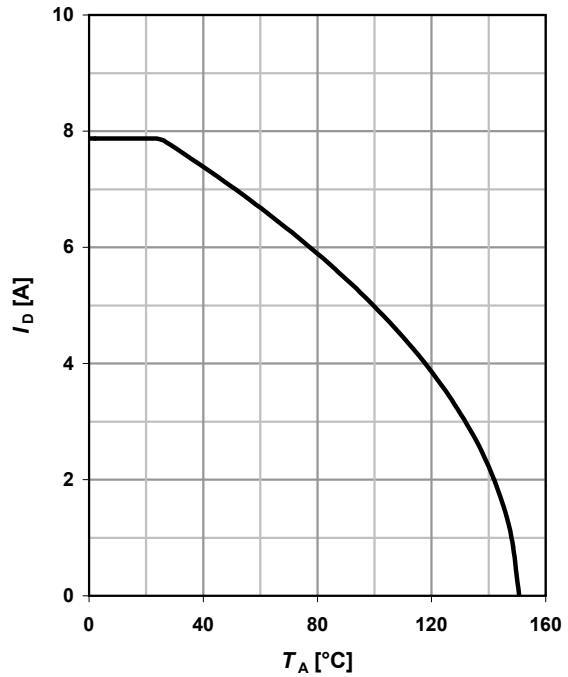
1 Power dissipation

$P_{tot}=f(T_A); t_p \leq 10 \text{ s}$



2 Drain current

$I_D=f(T_A); V_{GS} \geq 10 \text{ V}; t_p \leq 10 \text{ s}$



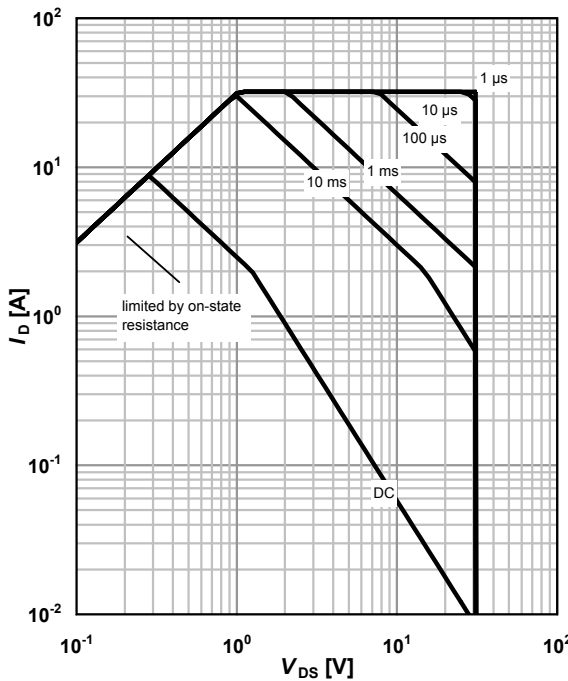
3 Safe operating area

Thermal resistance,

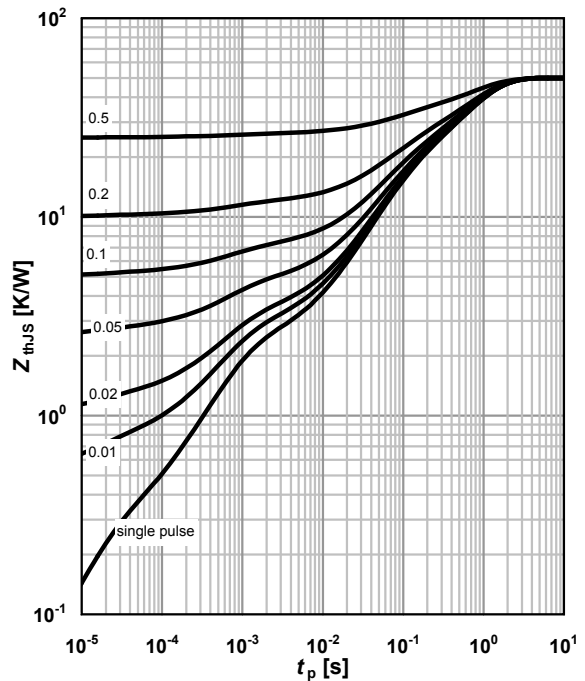
junction - solderir $Z_{thJS}=f(t_p)$

Thermal resistance,

junction - ambier parameter: $D=t_p/T$



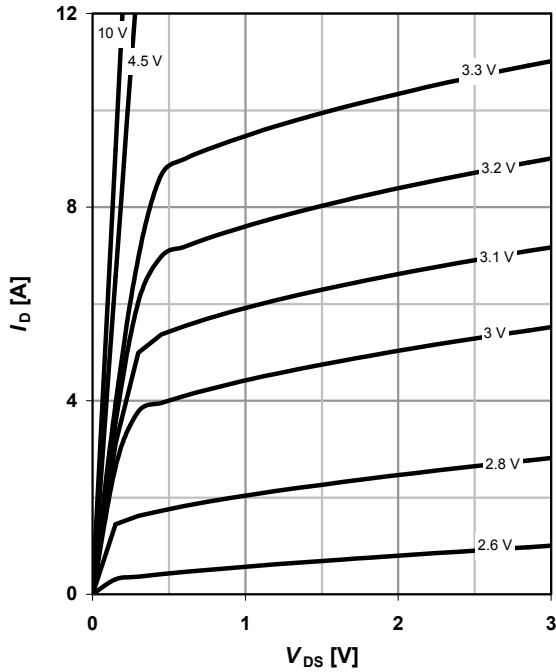
4 Max. transient thermal impedance



5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}$

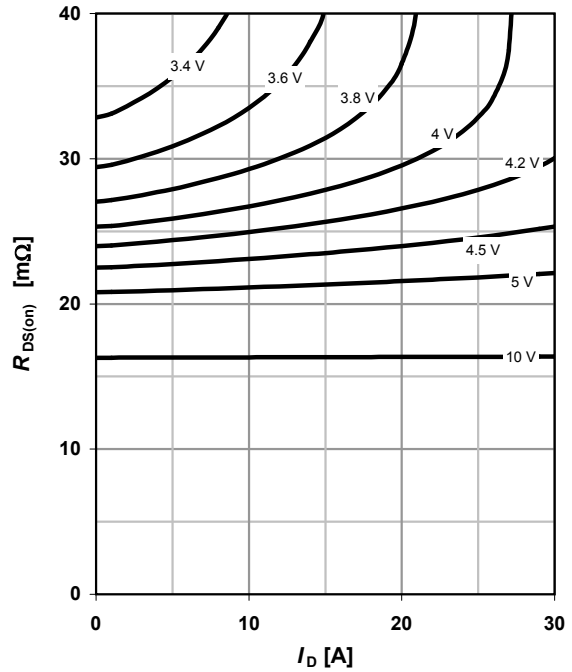
parameter: V_{GS}



6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

parameter: V_{GS}



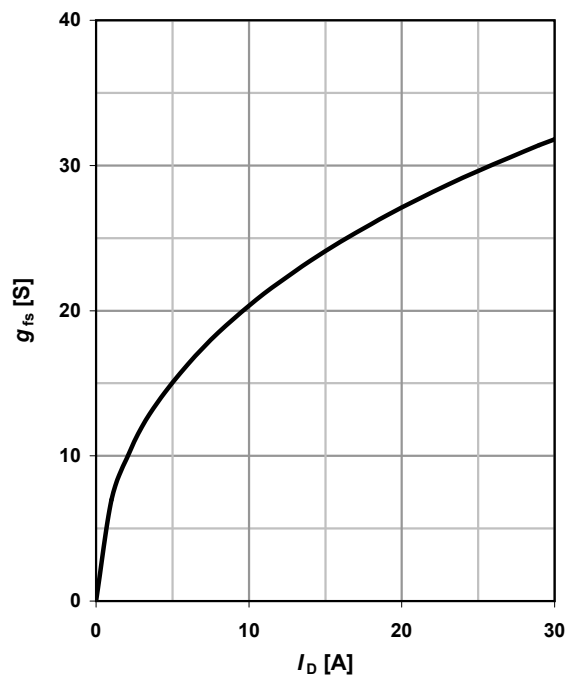
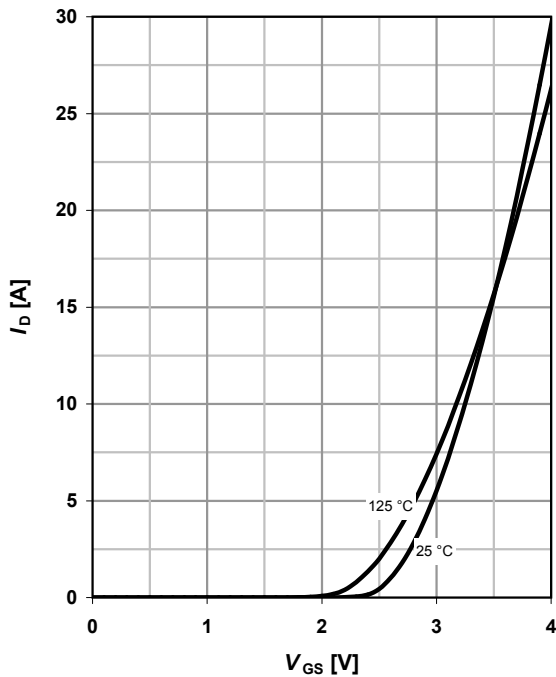
7 Typ. transfer characteristics

Thermal resistance, junction - solder

$g_{fs} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

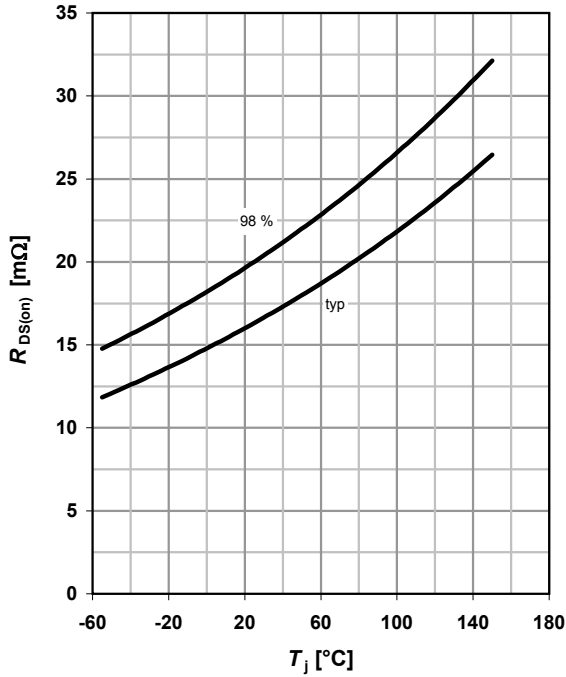
Thermal resistance, junction - ambient

8 Typ. forward transconductance



9 Drain-source on-state resistance

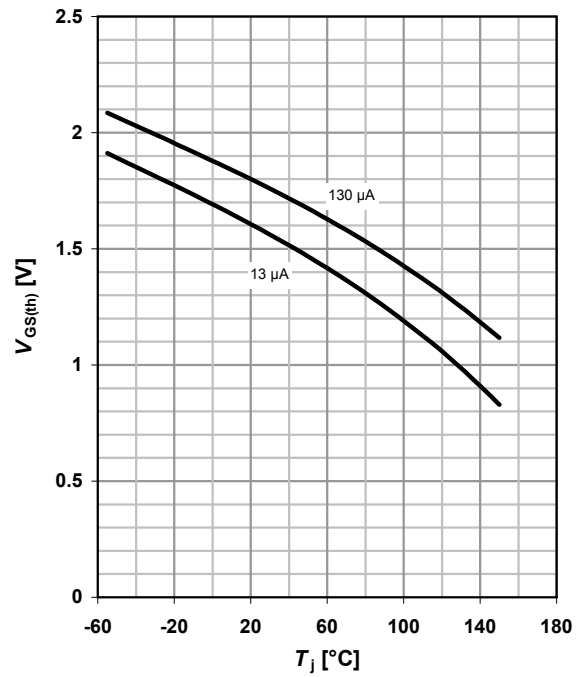
$R_{DS(on)} = f(T_j); I_D = 7.9 \text{ A}; V_{GS} = 10 \text{ V}$



10 Typ. gate threshold voltage

$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D



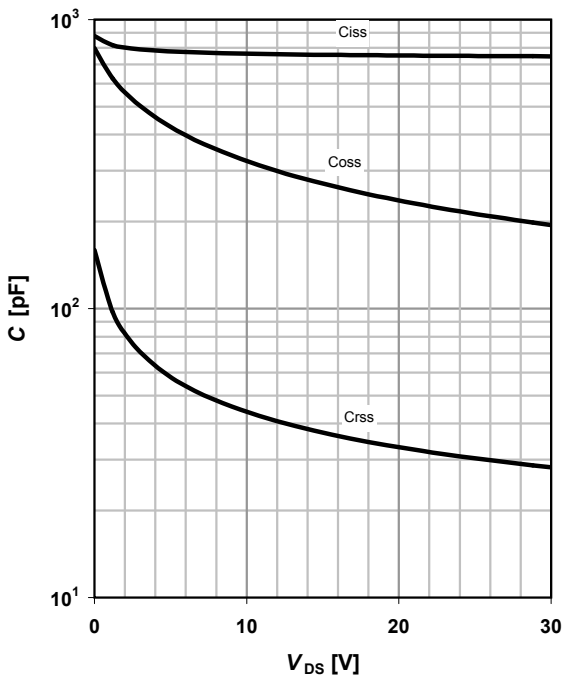
11 Typ. capacitances

Thermal resistance, junction - solder

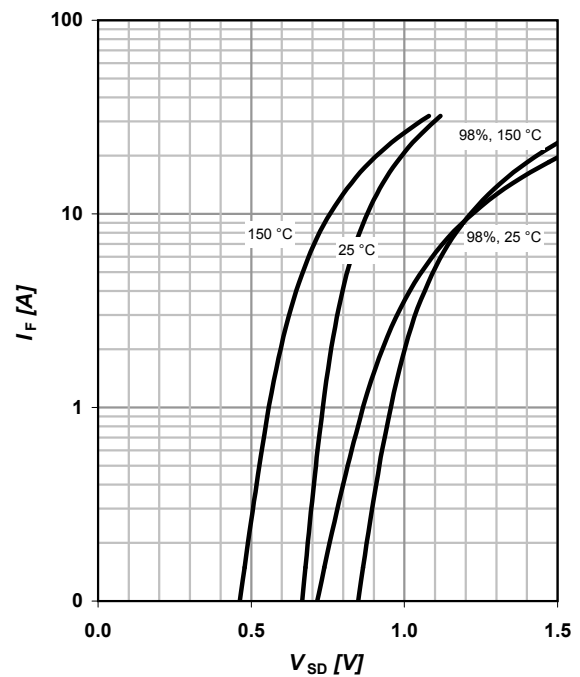
$I_F = f(V_{SD})$

Thermal resistance, junction - ambier

parameter: T_j



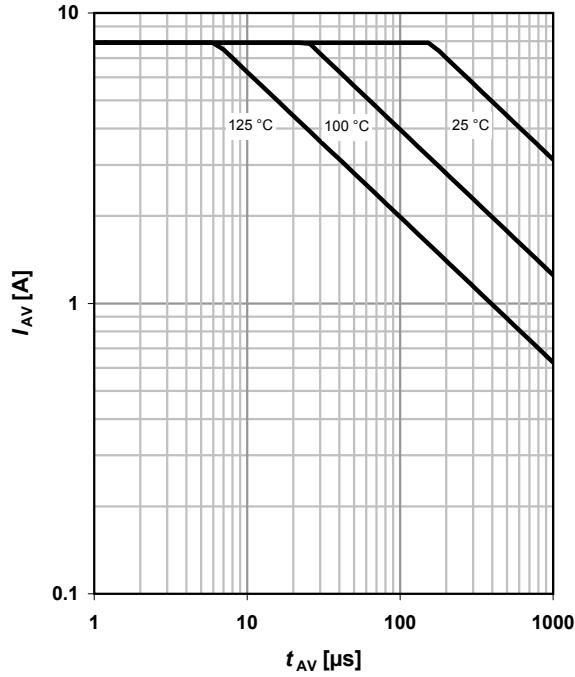
12 Forward characteristics of reverse diode



13 Avalanche characteristics

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

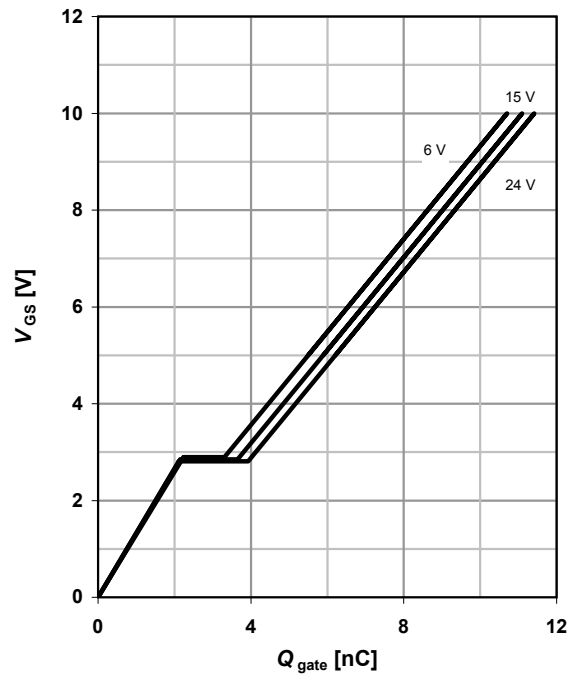
parameter: $T_{j(start)}$



14 Typ. gate charge

$V_{GS}=f(Q_{gate}); I_D=3.9 \text{ A pulsed}$

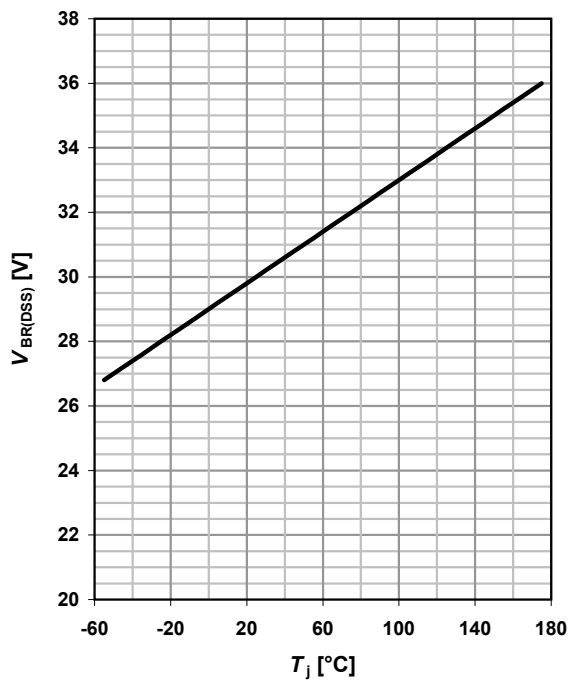
parameter: V_{DD}



15 Drain-source breakdown voltage

Thermal resistance, junction - soldering point

Thermal resistance, junction - ambient

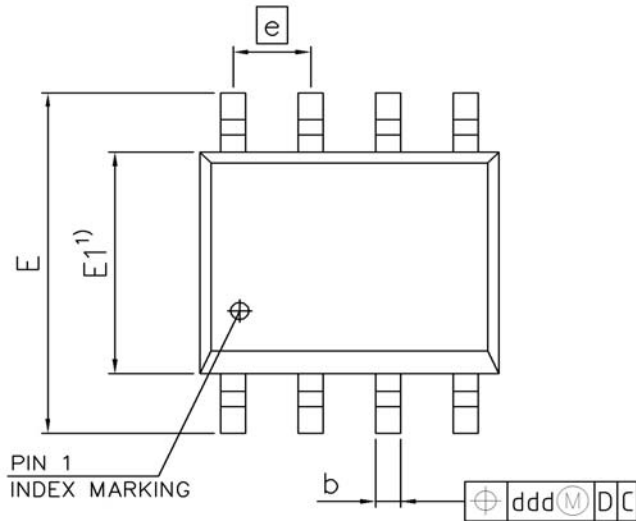
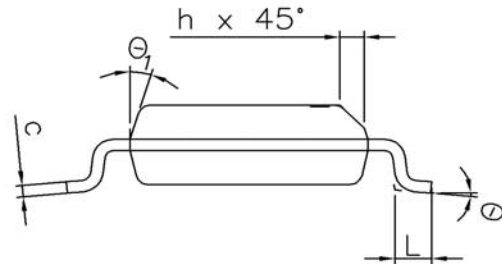
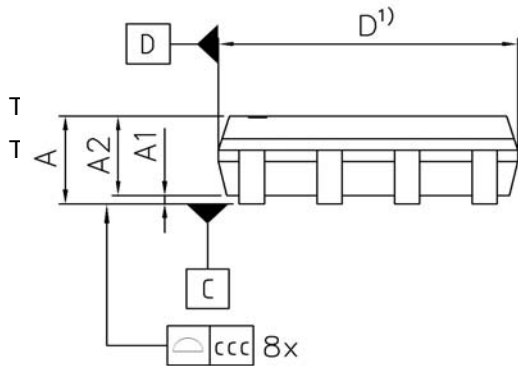


16 Gate charge waveforms

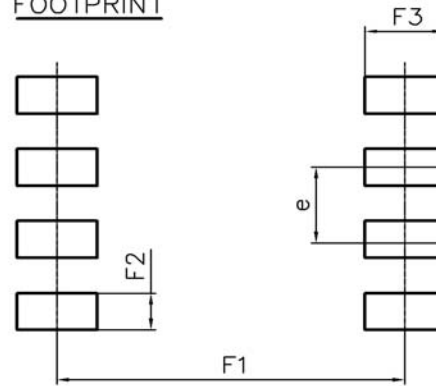


Package Outline

PG-DSO-8



FOOTPRINT



1) DOES NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	-	1.75	-	0.069
A1	0.10	-	0.004	-
A2	1.25	1.65	0.049	0.065
b	0.35	0.51	0.014	0.020
c	0.17	0.25	0.007	0.010
D	4.80	5.00	0.189	0.197
E	5.80	6.20	0.228	0.244
E1	3.80	4.00	0.150	0.157
e	1.27		0.050	
N	8		8	
L	0.39	0.89	0.015	0.035
h	0.23	0.50	0.009	0.020
Θ	0°	8°	0°	8°
Θ1	-	19°	-	19°
ccc	0.10		0.004	
ddd	0.25		0.010	
F1	5.59	5.79	0.220	0.228
F2	0.55	0.75	0.022	0.030
F3	1.21	1.41	0.048	0.056

DOCUMENT NO.
Z8B00003333

SCALE

EUROPEAN PROJECTION

ISSUE DATE
09.01.2008

REVISION
02

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Infineon Technologies AG
81726 Munich, Germany
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